Yingdi Liu

List of Publications by Year in descending order

Source: https://exaly.com/author-pdf/2869578/publications.pdf

Version: 2024-02-01

1937685 2272923 91 7 4 4 citations h-index g-index papers 7 7 7 34 docs citations citing authors times ranked all docs

#	Article	IF	CITATIONS
1	Time and Area Optimized Testing of Automotive ICs. IEEE Transactions on Very Large Scale Integration (VLSI) Systems, 2021, 29, 76-88.	3.1	10
2	X-Tolerant Compactor maXpress for In-System Test Applications With Observation Scan. IEEE Transactions on Very Large Scale Integration (VLSI) Systems, 2021, 29, 1553-1566.	3.1	4
3	Deterministic Stellar BIST for Automotive ICs. IEEE Transactions on Computer-Aided Design of Integrated Circuits and Systems, 2020, 39, 1699-1710.	2.7	11
4	X-Tolerant Tunable Compactor for In-System Test. , 2020, , .		2
5	Deterministic Stellar BIST for In-System Automotive Test. , 2018, , .		19
6	Staggered ATPG with capture-per-cycle observation test points. , 2018, , .		10
7	Embedded Deterministic Test Points. IEEE Transactions on Very Large Scale Integration (VLSI) Systems, 2017, 25, 2949-2961.	3.1	35